Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/681,088	SOMEYA ET AL.
Examiner	Art Unit
Julie Anne Watko	2627

	SEARCHED				
Class	Subclass	Date	Examiner		
360	246				
360	245.9				
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360	244				
360	240				
360	264.2				
360	266.3	12/5/2005	JAW		
updated	above	3/24/2006	WAL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
see	attached	3/24/2006	JAW	
L				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
INSPEC search. IEEExplore search. EAT search,	12/5/2005	JAW
CiteSeer search for citations to Chen et al, IEEE Trans. Mag. v. 30 no. 5 p. 2818, Sept 1994.	12/5/2005	JAW